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TECHNICAL DATA SHEET

PSR-4000 D10ME/CA-40 D10 MS-00255201 MS-00255301 Feb.2016

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PSR-4000 D10ME/CA-40 D10

(UL Suffix: PSR-4000CB5 / CA-40CB5)

1. FEATURES

PSR-4000 D10ME/CA-40 D10 is two component, liquid photoimageable solder resist (alkaline developable type) with following features:

- a) High photosensitivity with black color, matt finished surface
- b) Excellent electroless Ni/Au resistance
- c) Excellent in water-soluble flux resistance
- d) Environment conscious with halogen free and low outgassing

2. SPECIFICATION

Main agent	PSR-4000 D10ME
Hardener	CA-40 D10
Color*	Black
Mixing ratio	Main agent : 70 / Hardener : 30 (By weight)
Viscosity*	100dPa/s (Cone plate Viscometer, 5min ⁻¹ / 25deg.C)
Solid Content*	69.0wt%
Specific gravity*	1.3
Tack dry window*	80deg.C / 55min (Maximum)
Exposure energy*	40 - 80mJ/cm ² (On solder mask) by OCR Direct Imaging Mechanics (Di-IMPACT DXE-3512) (Use cut filter blow 355nm)
Pot life*	24 hours (Stored in dark place, at below 25deg.C)
Shelf life	6 months (Stored in dark place at below 20deg.C)

^{*:} After mixing

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3. PROCESS CONDITION

Process		Range
PWB	FR-4, 1.6mm	
Pre-treatment	CA-8101 at MEC Amount of etching 1.0um	
Printing	#200-mesh Stainless screen	150-200mesh
Hold time	10min	10-20min
Tack dry	 Both sides simultaneous exposure 1st printing: 80deg.C/15min 2nd printing: 80deg.C/25min (Hot air convention oven) Single side exposure 80deg.C/30min (Hot air convection oven) 	80deg.C/10-20min 80deg.C/20-30min 80deg.C/20-50min
Exposure	80mJ/cm ² (on solder mask) Using by ORC Direct Imaging Exposure machine(Di-IMPACT DXP3512) *use cut filter below 355nm	40-100mJ/cm ²
Hold time	10min	10-20min
Development	Aqueous alkaline solution: 1wt% Na ₂ CO ₃ Temperature of developer: 30deg.C Spray pressure: 0.2MPa Developing time: 60sec	0.15-0.25MPa 60-100sec
Water rinse	Temperature of rinsing water : 25deg.C Spray pressure : 0.1MPa Rinsing time : 45sec	Below 30deg.C 0.1-0.15MPa 45-60sec
Post cure	150deg.C / 60min (Hot air convection oven)	45-90min
UV Bump	1000mJ/cm ² (High pressure mercury lamp)	500-1000mJ/cm ²

^{*}In case of applying marking ink, solder mask should be cured at 150deg.C for 30 minutes, then marking ink should be cured at 140deg.C for 20 minutes x 2 cycles. In case no marking ink is applied, solder mask should be cured at 150deg.C for 60 minutes.

4. ATTENTION IN PROCESS:

- As to the operation environment. It is desirable to deal with the ink under the yellow lamps in the clean room. Please avoid using it under white fluorescent lamps or sunlight (directly or indirectly).
- After confirmation that ink becomes room temp., please start mixing in accordance with required amount of mixing ratio.
- The adequate thickness is 10 20 um (on the copper after curing).
 Thin coating possibly reduces its solder heat resistance. On the other hand, thick coating possibly causes the under-cut or low tackiness.

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- Please set the pre-cure conditions and tack dry window after the confirmation test because they are influenced according to the type of the drying machine and the quantity of the board to be dried.
- Please set the exposing energy after the confirmation test of under-cut, surface gloss, back side exposure and so on because it is influenced according to the material of the board, the thickness of ink, etc.
- Regarding the developing process, please control the developer density, the temperature, the spray pressure and the developer time, etc. The inadequacy of control causes the degradation of the developability and the increase of under-cut.
- Please set the post cure conditions considering the curing time of the marking ink. Insufficient curing or over curing may cause the degradation of properties.
- In order to ensure ENIG resistance, please set up appropriate post cure conditions with considering final baking of marking ink. ENIG resistance could be deteriorated due to over baking.

5. CHARACTERISTIC

(1) TACK DRY WINDOW

Drying time (80deg.C / min)	40	50	60	70
Developability	Clean	Clean	Slight Residue	Residue

(2) PHOTOSENSITIVITY

Item	Thickness	Energy	Developing time	Sensitivity
Sensitivity Stouffer T4105 (Step density tablet)	11 +/- 2um	40mJ/cm ²	60 sec.	18 step
		60mJ/cm ²		22 step
		80mJ/cm ²		25 step
		100mJ/cm ²		27 step
Resolution (Between QFP)	22+/- 1um	40mJ/cm ²	60 sec.	50um
		60mJ/cm ²		50um
		80mJ/cm ²		50um
		100mJ/cm ²		50um

The exposure energy is measured below Mylar film (on solder mask) by ORC HMW-680, 7Kw, metal halide lump.

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(3) END PROPERTIES

ltem	Test method	Test result	
Adhesion	TAIYO Internal Test Method Cross-cut tape stripping test	100 / 100	
Pencil hardness	TAIYO Internal Test Method On copper foil, no Cu exposure	6H	
Solder heat resistance	Solder float test : Rosin flux, 260deg.C/30sec (1cycle)	Passed	
	Solder float test : Water soluble flux, 260deg.C/30sec (1cycle)		
Solvent resistance	PGM-AC dipping, temp 20deg.C/20min, Scotch tape peeling test	Passed	
Acid resistance	10vol % H ₂ SO ₄ , temp 20deg.C/20min, Scotch tape peeling test	Passed	
Alkaline resistance	10wt% NaOH, temp 20deg.C/20min, Scotch tape peeling test	Passed	
Insulation resistance	IPC comb type B pattern Conditioned: DC100V 25-65deg.C(cycle) / 90% RH / 7 days Measurement: Room temp. DC500V 1-minute value	Initial: 2.0 x 10 ¹³ Ohms Conditioned: 3.7 x 10 ¹² Ohms	
Dielectric constant	TAIYO Internal Test Method, value at 1MHz Humidify: 25-65deg.C (cycle),90% RH,7days Measured: at room temperature	Initial: 3.5 Conditioned: 3.7	
Dissipation factor	TAIYO Internal Test Method, value at 1MHz Humidify: 25-65deg.C (cycle),90% RH, 7days Measured: at room temperature	Initial: 0.02 Conditioned: 0.03	
Electroless Ni/Au Plating resistance	TAIYO Internal Test Method Ni: 3um / Au: 0.03um	Passed	
Total halogen content	TAIYO Internal test method lon chromatography method(Measured value)	CI:257ppm Br:<20ppm	

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6. ATTENTION

- *All test data shown above on this technical data sheet are based on our laboratory test result and only for reference, not guarantee the same on your process.
- *All chemicals used in this product might have unknown toxicity. Please handle with your most care referring to the MSDS for use.
- *No intentional use of RoHS 2.0subjected 10 substances (Lead, Cadmium, Mercury, Hexavalent-chromium, PBBs, PBDEs, DEHP, DBP, BBP and DIBP) for this product.